MOSFET - Power, P-Channel, DPAK

-60 V, -12 A

This Power MOSFET is designed to withstand high energy in the avalanche and commutation modes. Designed for low-voltage, highspeed switching applications in power supplies, converters, and power motor controls. These devices are particularly well suited for bridge circuits where diode speed and commutating safe operating areas are critical and offer an additional safety margin against unexpected voltage transients.

Features

- Avalanche Energy Specified
- I_{DSS} and V_{DS(on)} Specified at Elevated Temperature
- Designed for Low-Voltage, High-Speed Switching Applications and to Withstand High Energy in the Avalanche and Commutation Modes
- NVD and SVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DSS}	-60	Vdc
Gate-to-Source Voltage - Continuous - Non-repetitive (t _p ≤ 10 ms)	V _{GS} V _{GSM}	± 20 ± 25	Vdc Vpk
Drain Current - Continuous @ $T_a = 25^{\circ}C$ - Single Pulse ($t_p \le 10 \text{ ms}$)	I _D I _{DM}	-12 -18	Adc Apk
Total Power Dissipation @ T _a = 25°C	P_{D}	55	W
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to 175	ç
Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J = 25^{\circ}C$ ($V_{DD} = 25$ Vdc, $V_{GS} = 10$ Vdc, Peak $I_L = 12$ Apk, $L = 3.0$ mH, $R_G = 25$ Ω)	E _{AS}	216	mJ
Thermal Resistance - Junction-to-Case - Junction-to-Ambient (Note 1) - Junction-to-Ambient (Note 2)	$egin{array}{c} R_{ heta JC} \ R_{ heta JA} \ R_{ heta JA} \end{array}$	2.73 71.4 100	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8 in. from case for 10 seconds	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

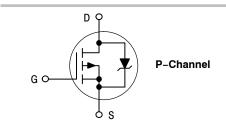
- 1. When surface mounted to an FR4 board using 1 in pad size (Cu area = 1.127 in^2).
- 2. When surface mounted to an FR4 board using the minimum recommended pad size (Cu area = 0.412 in^2).



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V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX
-60 V	155 mΩ @ –10 V, 6 A	-12 A



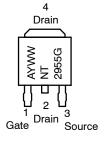


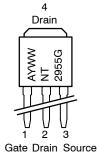




IPAK CASE 369D STYLE 2

MARKING DIAGRAMS **& PIN ASSIGNMENTS**





= Assembly Location*

NT2955/NV2955 = Specific Device Code (DPAK) NT2955 = Specific Device Code (IPAK)

WW = Work Week G = Pb-Free Package

* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

May, 2019 - Rev. 16

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

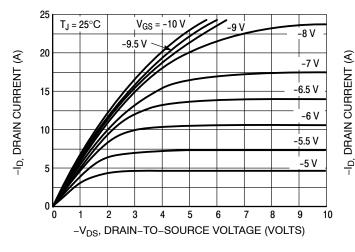
Cha	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS		•	•	•		•
Drain-to-Source Breakdown Volta $(V_{GS} = 0 \text{ Vdc}, I_D = -0.25 \text{ mA})$ (Positive Temperature Coefficient	V _{(BR)DSS}	-60 -	_ 67	- -	Vdc mV/°C	
Zero Gate Voltage Drain Current $(V_{GS} = 0 \text{ Vdc}, V_{DS} = -60 \text{ Vdc}, T (V_{GS} = 0 \text{ Vdc}, V_{DS} = -60 \text{ Vdc}, T)$	I _{DSS}	_ _	_ _	-10 -100	μAdc	
Gate-Body Leakage Current (V _{GS}	I _{GSS}	-	-	-100	nAdc	
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage (V _{DS} = V _{GS} , I _D = -250 μAdc) (Negative Temperature Coefficie	ent)	V _{GS(th)}	-2.0 -	-2.8 4.5	-4.0 -	Vdc mV/°C
Static Drain-Source On-State Rec (V _{GS} = -10 Vdc, I _D = -6.0 Adc)	R _{DS(on)}	-	0.155	0.180	Ω	
$\label{eq:controller} \begin{split} & \text{Drain-to-Source On-Voltage} \\ & \text{(V}_{GS} = -10 \text{ Vdc, I}_D = -12 \text{ Adc)} \\ & \text{(V}_{GS} = -10 \text{ Vdc, I}_D = -6.0 \text{ Adc,} \end{split}$	V _{DS(on)}		-1.86 -	-2.6 -2.0	Vdc	
Forward Transconductance (V _{DS} =	gFS		8.0	-	Mhos	
DYNAMIC CHARACTERISTICS		•				
Input Capacitance		C _{iss}	-	500	750	pF
Output Capacitance	(V _{DS} = -25 Vdc, V _{GS} = 0 Vdc, F = 1.0 MHz)	C _{oss}	-	150	250	
Reverse Transfer Capacitance	,	C _{rss}	-	50	100	
SWITCHING CHARACTERISTICS	(Notes 3 and 4)					
Turn-On Delay Time		t _{d(on)}	_	10	20	ns
Rise Time	(V _{DD} = -30 Vdc, I _D = -12 A,	t _r	_	45	85	
Turn-Off Delay Time	$V_{GS} = -10 \text{ V}, R_G = 9.1 \Omega$	t _{d(off)}	-	26	40	1
Fall Time		t _f	-	48	90	
Gate Charge		Q _T	-	15	30	nC
	$(V_{DS} = -48 \text{ Vdc}, V_{GS} = -10 \text{ Vdc}, $ $I_{D} = -12 \text{ A})$	Q _{GS}	-	4.0	-]
	,	Q_{GD}	-	7.0	-	
DRAIN-SOURCE DIODE CHARAC	CTERISTICS (Note 3)					
Diode Forward On-Voltage ($I_S = 12$ Adc, $V_{GS} = 0$ V) ($I_S = 12$ Adc, $V_{GS} = 0$ V, $T_J = 15$	V _{SD}	-	-1.6 -1.3	-2.5 -	Vdc	
Reverse Recovery Time	-10	t _{rr}	-	50		ns
$(I_S = 12 \text{ A}, dI_S/dt = 100 \text{ A}/\mu \text{s}, V_{GS} = 0 \text{ V})$		t _a	-	40	-]
	t _b	-	10	-]	
Reverse Recovery Stored Charge		Q _{RR}	-	0.10	-	μС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Indicates Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperature.

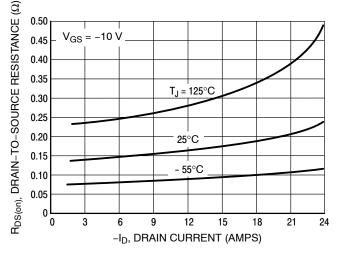
TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)



24 $T_J = -55^{\circ}C$ 22 $V_{DS} \ge -10 \text{ V}$ 125°C 20 18 16 14 12 10 0 | 3 8 9 10 -V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



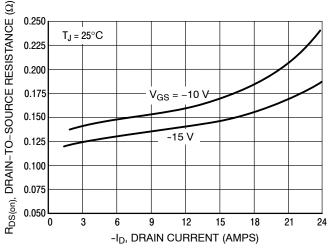
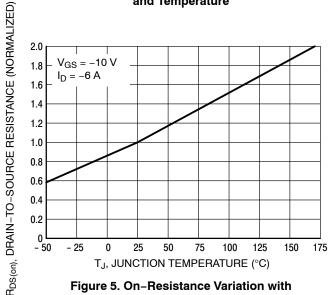


Figure 3. On-Resistance versus Drain Current and Temperature

Figure 4. On-Resistance versus Drain Current and Gate Voltage



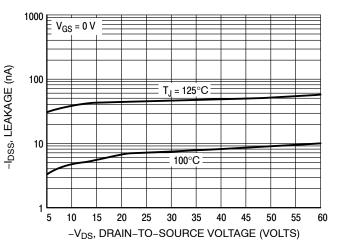
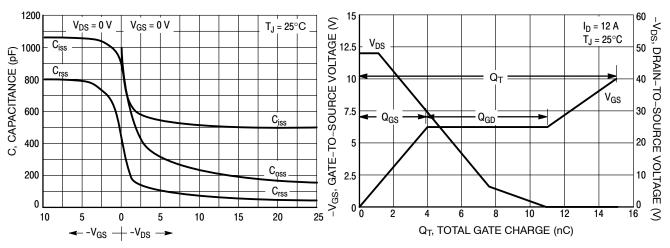


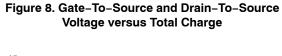
Figure 5. On-Resistance Variation with **Temperature**

Figure 6. Drain-To-Source Leakage **Current versus Voltage**



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (V)

Figure 7. Capacitance Variation



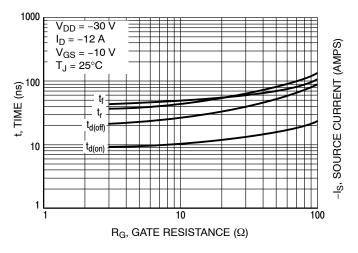


Figure 9. Resistive Switching Time Variation versus Gate Resistance

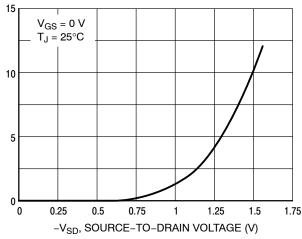


Figure 10. Diode Forward Voltage versus Current

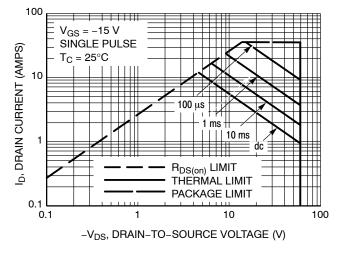


Figure 11. Maximum Rated Forward Biased Safe Operating Area

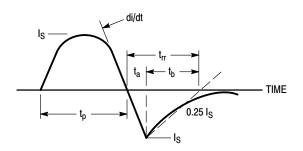


Figure 12. Diode Reverse Recovery Waveform

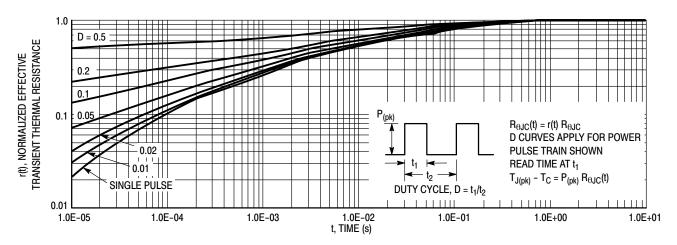


Figure 13. Thermal Response

ORDERING INFORMATION

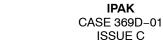
Device	Package	Shipping [†]
NTD2955G	DPAK (Pb-Free)	75 Units / Rail
NTD2955-1G	IPAK (Pb-Free)	75 Units / Rail
NTD2955T4G	DPAK (Pb-Free)	2500 / Tape & Reel
NVD2955T4G*	DPAK (Pb-Free)	2500 / Tape & Reel
SVD2955T4G*	DPAK (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{*}NVD and SVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.

MECHANICAL CASE OUTLINE





STYLE 3: PIN 1. ANODE

2. CATHODE

4. CATHODE

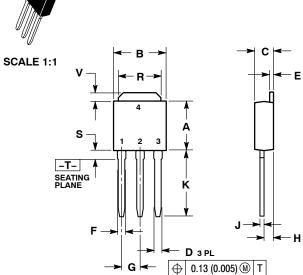
3 ANODE

STYLE 7: PIN 1. GATE 2. COLLECTOR

3. EMITTER

COLLECTOR

DATE 15 DEC 2010



STYLE 2:

PIN 1. GATE

3

STYLE 6: PIN 1. MT1 2. MT2 3. GATE

2. DRAIN

4. DRAIN

MT2

SOURCE

STYLE 1: PIN 1. BASE

3

STYLE 5: PIN 1. GATE

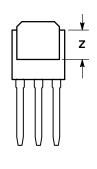
2. ANODE 3. CATHODE

ANODE

2. COLLECTOR

EMITTER

COLLECTOR



NOTES:

- DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

MARKING DIAGRAMS

STYLE 4:
PIN 1. CATHODE
2. ANODE
3. GATE
4. ANODE
Discrete

XXXXX

ALYWW

XXXXXXXX

X

xxxxxxxxx = Device Code
A = Assembly Location
IL = Wafer Lot
Y = Year
WW = Work Week

	IPAK (DPAK INSERTION MOUNT)		
DOCUMENT NUMBER: 9		Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLED 0"	

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В

NOTE 7

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Α1

- h3

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TOP VIEW

L3

b2 e

L2 GAUGE

DPAK (SINGLE GAUGE) CASE 369C **ISSUE F** SCALE 1:1 Α

DETAIL A

C SEATING

C-

SIDE VIEW

DATE 21 JUL 2015

NOTES:

z

BOTTOM VIEW

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES.
- 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-
- MENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
 5. DIMENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY.

 6. DATUMS A AND B ARE DETERMINED AT DATUM
- 7. OPTIONAL MOLD FEATURE.

	INCHES		MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114	0.114 REF		REF
L2	0.020	0.020 BSC		BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

ALTERNATE CONSTRUCTIONS **DETAIL A** ROTATED 90° CW **GENERIC** STYLE 1: STYLE 2: STYLE 3: STYLE 4: STYLE 5: PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE PIN 1. BASE 2. COLLECTOR 3. EMITTER 4. COLLECTOR PIN 1. ANODE 2. CATHODE 3. ANODE 4. CATHODE PIN 1. GATE 2. ANODE 3. CATHODE 4. ANODE PIN 1. GATE 2. DRAIN

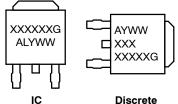
Z

BOTTOM VIEW

С

3. EMITTE 4. COLLE	ER .	3. SOURCE 4. DRAIN	3. AN	ODE THODE	3. GATE 4. ANODE	3.	CATHODE ANODE
STYLE 6: PIN 1. MT1 2. MT2 3. GATE	STYLE 7: PIN 1. GATE 2. COLLE 3. EMITT	PII ECTOR	'LE 8: N 1. N/C 2. CATHODE 3. ANODE		ODE THODE SISTOR ADJUS	2.	0: CATHODE ANODE CATHODE
4. MT2	COLLE	ECTOR	CATHODE	4. CA	THODE	4.	ANODE

MARKING DIAGRAM*



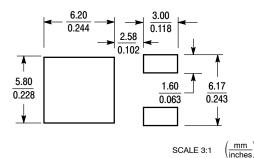
XXXXXX = Device Code = Assembly Location Α L = Wafer Lot Υ = Year WW = Work Week

*This information is generic. Please refer to device data sheet for actual part marking.

= Pb-Free Package

G

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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